

Notice of References Cited	Application/Control No. 09/596,746		Applicant(s)/Patent Under Reexamination DATTWYLER ET AL.	
	Examiner Rodney P. Swartz, Ph.D.		Art Unit 1645	Page 1 of 3

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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